











SN74LVC2G08

SCES198N - APRIL 1999 - REVISED DECEMBER 2015

SN74LVC2G08 Dual 2-Input Positive-AND Gate

Features

- Available in the Texas Instruments NanoStar™ and NanoFree™ Package
- Supports 5-V V_{CC} Operation
- Inputs Accept Voltages to 5.5 V
- Max t_{pd} of 4.7 ns at 3.3 V
- Low Power Consumption, 10-µA Maximum I_{CC}
- ±24-mA Output Drive at 3.3 V
- Typical V_{OLP} (Output Ground Bounce) <0.8 V at $V_{CC} = 3.3 \text{ V}$, $T_A = 25^{\circ}\text{C}$
- Typical V_{OHV} (Output V_{OH} Undershoot) >2 V at V_{CC} = 3.3 V, T_A = 25°C
- I_{off} Supports Live Insertion, Partial-Power-Down Mode, and Back-Drive Protection
- Can Be Used as a Down Translator to Translate Inputs From a Maximum of 5.5 V Down to the V_{CC}
- Latch-Up Performance Exceeds 100 mA Per JESD 78, Class II
- ESD Protection Exceeds JESD 22
 - 2000-V Human Body Model (A114-A)
 - 1000-V Charged-Device Model (C101)

Applications

- IP Phones: Wired and Wireless
- Optical Networking: EPON and Video Over Fiber
- Point-to-Point Microwave Backhaul
- Power: Telecom DC/DC Module: Analog
- Power: Telecom DC/DC Module: Digital
- Private Branch Exchange (PBX)
- Telecom Shelter: Power Distribution Unit (PDU)
- Vector Signal Analyzers and Generators
- Wireless Communications Testers
- Wireless Repeaters
- xDSL Modem/DSLAM

3 Description

This dual 2-input positive-AND gate is designed for 1.65-V to 5.5-V V_{CC} operation.

The SN74LVC2G08 device performs the Boolean function Y = A × B or Y = $\overline{A} + \overline{B}$ in positive logic.

NanoFree package technology is breakthrough in IC packaging concepts, using the die as the package.

This device is fully specified for partial-power-down applications using Ioff. The Ioff circuitry disables the outputs, preventing damaging current backflow through the device when it is powered down.

Device Information⁽¹⁾

| PART NUMBER | PACKAGE | BODY SIZE (NOM) | | |
|----------------|-----------|-------------------|--|--|
| SN74LVC2G08DCT | SM8 (8) | 2.95 mm × 2.80 mm | | |
| SN74LVC2G08DCU | VSSOP (8) | 2.30 mm × 2.00 mm | | |
| SN74LVC2G08YZP | DSBGA (8) | 1.91 mm × 0.91 mm | | |

(1) For all available packages, see the orderable addendum at the end of the data sheet.

Logic Diagram (Positive Logic)

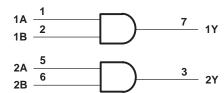




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4 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

Changes from Revision M (April 2014) to Revision N

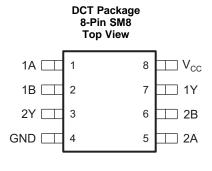
Page

Added Pin Configuration and Functions section, ESD Ratings and Thermal Information tables, Feature Description section, Device Functional Modes section, Application and Implementation section, Power Supply Recommendations section, Layout section, Device and Documentation Support section, and Mechanical, Packaging, and Orderable Information section

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5 Pin Configuration and Functions







YZP Package 8-Pin DSBGA Bottom View

| GND | 0450 | 2A |
|-----|-------|-----------------|
| 2Y | O3 6O | 2B |
| 1B | 0270 | 1Y |
| 1A | O18O | V _{CC} |

Pin Functions⁽¹⁾

| PIN | | 1/0 | DESCRIPTION | | |
|-----------------|-----|-----|-----------------------|--|--|
| NAME | NO. | 1/0 | DESCRIPTION | | |
| 1A | 1 | I | Channel 1 logic input | | |
| 1B | 2 | I | Channel 1 logic input | | |
| 1Y | 7 | 0 | Logic level output | | |
| 2A | 5 | I | Channel 2 logic input | | |
| 2B | 6 | I | Channel 2 logic input | | |
| 2Y | 3 | 0 | Logic level output | | |
| GND | 4 | _ | Ground | | |
| V _{CC} | 8 | _ | Power Supply | | |

(1) See Mechanical, Packaging, and Orderable Information for dimensions.



6 Specifications

6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)⁽¹⁾

| | | | IIM | N MAX | UNIT |
|------------------|---|---------------------------------------|-----|----------------|------|
| V _{CC} | Supply voltage | | -0. | 5 6.5 | V |
| VI | Input voltage (2) | | -0. | 5 6.5 | V |
| Vo | Voltage applied to any output in the high-impedar | nce or power-off state ⁽²⁾ | -0. | 5 6.5 | V |
| Vo | Voltage applied to any output in the high or low st | tate ⁽²⁾⁽³⁾ | -0. | $V_{CC} + 0.5$ | V |
| I _{IK} | Input clamp current | V _I < 0 | | -50 | mA |
| I _{OK} | Output clamp current | V _O < 0 | | -50 | mA |
| Io | Continuous output current | | | ±50 | mA |
| | Continuous current through V _{CC} or GND | | | ±100 | mA |
| Tj | Junction temperature | | | 150 | °C |
| T _{stg} | Storage temperature | | -65 | 5 150 | °C |

⁽¹⁾ Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

6.2 ESD Ratings

| | | | VALUE | UNIT |
|--------------------|---------------|---|-------|------|
| V | Electrostatic | Human body model (HBM), per ANSI/ESDA/JEDEC JS-001 (1) | ±2000 | V |
| V _(ESD) | discharge | Charged-device model (CDM), per JEDEC specification JESD22-C101 (2) | ±1000 | V |

Product Folder Links: SN74LVC2G08

(2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

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⁽²⁾ The input negative-voltage and output voltage ratings may be exceeded if the input and output current ratings are observed.

⁽³⁾ The value of V_{CC} is provided in the *Recommended Operating Conditions* table.

⁽¹⁾ JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.



6.3 Recommended Operating Conditions⁽¹⁾

| | | | MIN | MAX | UNIT | | |
|--------------------|---|--|------------------------|------------------------|------|--|--|
| . , | O complex conflictions | Operating | 1.65 | 5.5 | | | |
| vcc | Supply voltage | Data retention only | 1.5 | | V | | |
| | | V _{CC} = 1.65 V to 1.95 V | 0.65 × V _{CC} | | | | |
| . , | | V _{CC} = 2.3 V to 2.7 V | 1.7 | | ., | | |
| V _{IH} | Data retention only $V_{CC} = 1.65 \text{ V to } 1.95 \text{ V} \qquad 0.65$ $V_{CC} = 2.3 \text{ V to } 3.6 \text{ V}$ $V_{CC} = 3 \text{ V to } 3.6 \text{ V}$ $V_{CC} = 4.5 \text{ V to } 1.95 \text{ V} \qquad 0.7$ $V_{CC} = 3 \text{ V to } 3.6 \text{ V}$ $V_{CC} = 3.3 \text{ V to } 3.6 \text{ V}$ $V_{CC} = 3.3 \text{ V to } 3.6 \text{ V}$ $V_{CC} = 3.3 \text{ V to } 3.6 \text{ V}$ $V_{CC} = 3.3 \text{ V to } 3.6 \text{ V}$ $V_{CC} = 3.5 \text{ V to } 5.5 \text{ V}$ Input voltage $V_{CC} = 4.5 \text{ V to } 5.5 \text{ V}$ $V_{CC} = 2.3 \text{ V}$ $V_{CC} = 3.3 \text{ V}$ $V_{CC} = 2.3 \text{ V}$ $V_{CC} = 2.3 \text{ V}$ $V_{CC} = 3.3 \text{ V}$ | 2 | | V | | | |
| | | V _{CC} = 4.5 V to 5.5 V | 0.7 × V _{CC} | | | | |
| | | V _{CC} = 1.65 V to 1.95 V | | 0.35 × V _{CC} | | | |
| V _{IL} Lo | Lavo laval Sanut valta va | V _{CC} = 2.3 V to 2.7 V | | 0.7 | ., | | |
| | Low-level input voltage | V _{CC} = 3 V to 3.6 V | | 0.8 | V | | |
| | | V _{CC} = 4.5 V to 5.5 V | | 0.3 × V _{CC} | | | |
| VI | Input voltage | | 0 | 5.5 | V | | |
| Vo | Output voltage | | 0 | V _{CC} | V | | |
| | | V _{CC} = 1.65 V | | -4 | | | |
| | | V _{CC} = 2.3 V | | -8 | | | |
| ОН | High-level output current | V 2V | | -16 | mA | | |
| | | V _{CC} = 3 V | | -24 | | | |
| | | V _{CC} = 4.5 V | | -32 | | | |
| | | V _{CC} = 1.65 V | | 4 | | | |
| | | V _{CC} = 2.3 V | | 8 | | | |
| I_{OL} | Low-level output current | | | 16 | mA | | |
| | | V _{CC} = 3 V | | 24 | | | |
| | | V _{CC} = 4.5 V | | 32 | | | |
| | | $V_{CC} = 1.8 \text{ V} \pm 0.15 \text{ V}, 2.5 \text{ V} \pm 0.2 \text{ V}$ | | 20 | | | |
| ∆t/Δv | Input transition rise or fall rate | $V_{CC} = 3.3 \text{ V} \pm 0.3 \text{ V}$ | | 10 | | | |
| | | $V_{CC} = 5 V \pm 0.5 V$ | | 5 | | | |
| | | SN74LVC2G08DCU | -40 | 125 | | | |
| T _A | Operating free-air temperature | SN74LVC2G08DCT | -40 | 125 | °C | | |
| | | SN74LVC2G08YZP | -40 | 85 | | | |

⁽¹⁾ All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.

6.4 Thermal Information

| | THERMAL METRIC ⁽¹⁾ | DCT (SM8) | DCU (VSSOP) | YZP (DSBGA) | UNIT |
|----------------------|---|-----------|-------------|-------------|------|
| | | 8 PINS | 8 PINS | 8 PINS | |
| $R_{\theta JA}$ | Junction-to-ambient thermal resistance | 220 | 227 | 128 | °C/W |
| $R_{\theta JC(top)}$ | Junction-to-case (top) thermal resistance | 108 | 84 | 14 | °C/W |

⁽¹⁾ For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report, SPRA953.



6.5 Electrical Characteristics

over recommended operating free-air temperature range (unless otherwise noted)

| PARAMETER | TEST CONDITIONS | V _{cc} | MIN | TYP ⁽¹⁾ | MAX | UNIT |
|------------------------------|---|-----------------|-----------------------|--------------------|------|------|
| | I _{OH} = -100 μA | 1.65 V to 5.5 V | V _{CC} - 0.1 | | | |
| V _{OH} | $I_{OH} = -4 \text{ mA}$ | 1.65 V | 1.2 | | | |
| | $I_{OH} = -8 \text{ mA}$ | 2.3 V | 1.9 | | | V |
| | $I_{OH} = -16 \text{ mA}$ | 3 V | 2.4 | | | V |
| | $I_{OH} = -24 \text{ mA}$ | 3 V | 2.3 | | | |
| | $I_{OH} = -32 \text{ mA}$ | 4.5 V | 3.8 | | | |
| | I _{OL} = 100 μA | 1.65 V to 5.5 V | | | 0.1 | |
| | I _{OL} = 4 mA | 1.65 V | | | 0.45 | |
| | I _{OL} = 8 mA | 2.3 V | | | 0.3 | V |
| V _{OL} | I _{OL} = 16 mA | 3 V | | 0.4 | | |
| | I _{OL} = 24 mA | 3 V | | | 0.55 | |
| | I _{OL} = 32 mA | 4.5 V | | | 0.55 | |
| I _I A or B inputs | V _I = 5.5 V or GND | 0 to 5.5 V | | | ±5 | μΑ |
| l _{off} | V_I or $V_O = 5.5 \text{ V}$ | 0 | | | ±10 | μΑ |
| I _{cc} | V _I = 5.5 V or GND, I _O = 0 | 1.65 V to 5.5 V | | | 10 | μΑ |
| ΔI _{CC} | One input at V_{CC} – 0.6 V, Other inputs at V_{CC} or GND, $T_A = -40^{\circ}\text{C}$ to 85°C | 3 V to 5.5 V | | | 500 | μА |
| C _i | $V_I = V_{CC}$ or GND, $T_A = -40$ °C to 85°C | 3.3 V | | 5 | | |
| 0 | f 40 MHz T 4000 to 0500 | 1.8 V to 3.3V | | 17 | | |
| C_{pd} | $f = 10 \text{ MHz}, T_A = -40^{\circ}\text{C to } 85^{\circ}\text{C}$ | 5 V | | 20 | | |

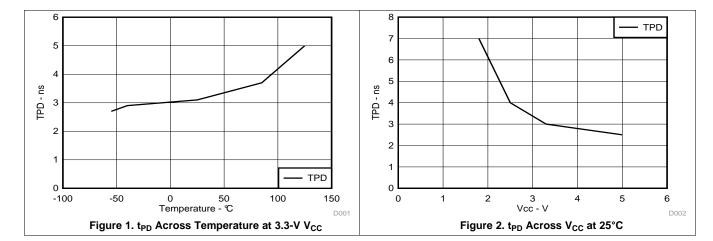
⁽¹⁾ All typical values are at V_{CC} = 3.3 V, T_A = 25°C.

6.6 Switching Characteristics

| PARAMETER | FROM (INPUT) | TO (OUTPUT) | T _A | V _{cc} | MIN | MAX | UNIT |
|-----------------|-----------------|----------------|----------------|--|-----|-----|------|
| | | | | V _{CC} = 1.8 V ± 0.15 V | 2.6 | 9 | |
| | | | 40°C to 05°C | V _{CC} = 2.5 V ± 0.2 V | 1 | 5.1 | |
| | A or B | Y | −40°C to 85°C | $V_{CC} = 3.3 \text{ V} \pm 0.3 \text{ V}$ | 1 | 4.7 | ns |
| | | | | V _{CC} = 5 V ± 0.5 V | 1 | 3.8 | |
| t _{pd} | | | -40°C to 125°C | V _{CC} = 1.8 V ± 0.15 V | 2.6 | 9.8 | |
| | | | | V _{CC} = 2.5 V ± 0.2 V | 1 | 5.8 | |
| | | | | $V_{CC} = 3.3 \text{ V} \pm 0.3 \text{ V}$ | 1 | 5.3 | |
| | | | | V _{CC} = 5 V ± 0.5 V | 1 | 4.8 | |



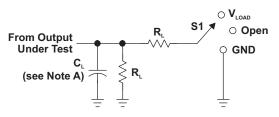
6.7 Typical Characteristics



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7 Parameter Measurement Information



| TEST | S 1 |
|------------------------------------|---------------------|
| t _{PLH} /t _{PHL} | Open |
| t _{PLZ} /t _{PZL} | \mathbf{V}_{LOAD} |
| t _{PHZ} /t _{PZH} | GND |

LOAD CIRCUIT

| ,, | INPUTS | | ., | ., | | 1 | ., |
|-----------------|-----------------|---------|--------------------|--------------------------|----------------|----------------------------|----------------------------------|
| V _{cc} | V, | t,/t, | V _M | V _{LOAD} | C _∟ | $R_{\scriptscriptstyle L}$ | $V_{\scriptscriptstyle{\Delta}}$ |
| 1.8 V ± 0.15 V | V _{cc} | ≤2 ns | V _{cc} /2 | 2 × V _{cc} | 30 pF | 1 k Ω | 0.15 V |
| 2.5 V ± 0.2 V | V_{cc} | ≤2 ns | V _{cc} /2 | 2 × V _{cc} | 30 pF | 500 Ω | 0.15 V |
| 3.3 V ± 0.3 V | 3 V | ≤2.5 ns | 1.5 V | 6 V | 50 pF | 500 Ω | 0.3 V |
| 5 V ± 0.5 V | V_{cc} | ≤2.5 ns | V _{cc} /2 | 2 × V _{cc} | 50 pF | 500 Ω | 0.3 V |



NOTES: A. C_L includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, Z_{\circ} = 50 Ω .
- D. The outputs are measured one at a time, with one transition per measurement.
- E. $t_{\mbox{\tiny PLZ}}$ and $t_{\mbox{\tiny PHZ}}$ are the same as $t_{\mbox{\tiny dis}}.$
- F. t_{PZL} and t_{PZH} are the same as t_{en} .
- G. t_{PLH} and t_{PHL} are the same as t_{pd} .
- H. All parameters and waveforms are not applicable to all devices.

Figure 3. Load Circuit and Voltage Waveforms

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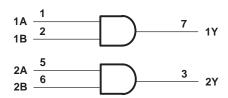


8 Detailed Description

8.1 Overview

The SN74LVC1G06 device contains two positive-AND gates with a maximum sink current of 24 mA. A very low tpd of 4.7ns at 3.3V makes the device ideal for high speed applications. Additionally, 5.5V tolerant inputs allow the device to be used as a down translator if needed.

8.2 Functional Block Diagram



8.3 Feature Description

8.3.1 Down Voltage Translation

SN74LVC2G08 allows for logic input and output signals up to 5.5 V. While operating at V_{CC} of 3.3 V, the device will still recognize 5.5 V as a valid high input, however, the resulting output will be 3.3 V. This is the same for other voltage levels in the device effectively down translating any input logic level higher than V_{CC} but lower or equal to 5.5 V.

8.4 Device Functional Modes

Table 1 lists the functional modes of the SN74LVC2G08.

Table 1. Function Table

| | INPUTS | OUTPUT | | | | |
|---|--------|--------|--|--|--|--|
| Α | В | Y | | | | |
| Н | Н | Н | | | | |
| L | X | L | | | | |
| Х | L | L | | | | |



9 Application and Implementation

NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

9.1 Application Information

The SN74LVC2G08 is a high-drive CMOS device that can be used for implementing AND logic with a high output drive, such as an LED application. It can produce 24 mA of drive current at 3.3 V, making it Ideal for driving multiple outputs and good for high-speed applications up to 100 MHz. The inputs are 5.5-V tolerant allowing it to translate down to $V_{\rm CC}$.

9.2 Typical Application

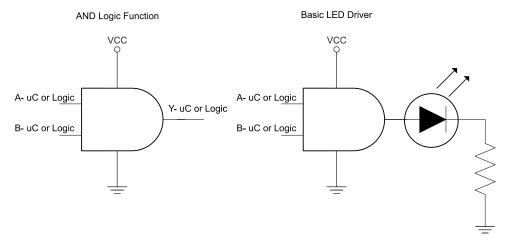


Figure 4. Typical Application

9.2.1 Design Requirements

This device uses CMOS technology and has balanced output drive. Tak care to avoid bus contention because it can drive currents that would exceed maximum limits. The high drive will also create fast edges into light loads so routing and load conditions must be considered to prevent ringing.

9.2.2 Detailed Design Procedure

- 1. Recommended Input Conditions
 - Rise time and fall time specs. See (Δt/ΔV) in the Recommended Operating Conditions table.
 - Specified high and low levels. See (V_{IH} and V_{IL}) in the Recommended Operating Conditions table.
 - Inputs are overvoltage tolerant allowing them to go as high as (V_I maximum) in the Recommended Operating Conditions table at any valid V_{CC}.

2. Recommended Output Conditions

- Load currents must not exceed (I_O maximum) per output and must not exceed total current (continuous current through V_{CC} or GND) for the part. These limits are located in the *Recommended Operating* Conditions table.
- Outputs must not be pulled above V_{CC} in normal operating conditions.

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Typical Application (continued)

9.2.3 Application Curves

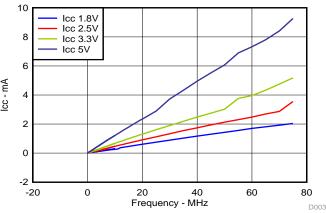


Figure 5. I_{CC} vs Frequency

10 Power Supply Recommendations

The power supply can be any voltage between the minimum and maximum supply voltage rating located in the *Recommended Operating Conditions* table. Each V_{CC} pin must have a good bypass capacitor to prevent power disturbance. For devices with a single supply, a 0.1- μ F capacitor is recommended and if there are multiple V_{CC} pins then 0.01- μ F or 0.022- μ F capacitor is recommended for each power pin. It is ok to parallel multiple bypass capacitors to reject different frequencies of noise. 0.1- μ F and 1- μ F capacitors are commonly used in parallel. The bypass capacitor must be installed as close to the power pin as possible for best results

11 Layout

11.1 Layout Guidelines

When using multiple bit logic devices inputs must not ever float. In many cases, functions or parts of functions of digital logic devices are unused; for example, when only two inputs of a triple-input AND gate are used or only 3 of the 4 buffer gates are used. Such input pins must not be left unconnected because the undefined voltages at the outside connections result in undefined operational states. Specified below are the rules that must be observed under all circumstances. All unused inputs of digital logic devices must be connected to a high or low bias to prevent them from floating. The logic level that must be applied to any particular unused input depends on the function of the device. Generally they will be tied to GND or V_{CC} whichever make more sense or is more convenient.

11.2 Layout Example



Figure 6. Layout Example



12 Device and Documentation Support

12.1 Community Resources

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

TI E2E™ Online Community TI's Engineer-to-Engineer (E2E) Community. Created to foster collaboration among engineers. At e2e.ti.com, you can ask questions, share knowledge, explore ideas and help solve problems with fellow engineers.

Design Support *TI's Design Support* Quickly find helpful E2E forums along with design support tools and contact information for technical support.

12.2 Trademarks

NanoStar, NanoFree, E2E are trademarks of Texas Instruments. All other trademarks are the property of their respective owners.

12.3 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

12.4 Glossary

SLYZ022 — TI Glossary.

This glossary lists and explains terms, acronyms, and definitions.

13 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.





3-Jul-2017

PACKAGING INFORMATION

| Orderable Device | Status (1) | Package Type | Package Drawing | Pins | Package Qty | Eco Plan | Lead/Ball Finish | MSL Peak Temp | Op Temp (°C) | Device Marking (4/5) | Samples |
|-------------------|------------|--------------|--------------------|------|----------------|----------------------------|-------------------|--------------------|--------------|---------------------------------|---------|
| SN74LVC2G08DCTR | ACTIVE | SM8 | DCT | 8 | 3000 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM | -40 to 125 | C08 (R ~ Z) | Samples |
| SN74LVC2G08DCTRE4 | ACTIVE | SM8 | DCT | 8 | 3000 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM | -40 to 125 | C08 (R ~ Z) | Samples |
| SN74LVC2G08DCTRG4 | ACTIVE | SM8 | DCT | 8 | 3000 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM | -40 to 125 | C08 (R ~ Z) | Samples |
| SN74LVC2G08DCUR | ACTIVE | VSSOP | DCU | 8 | 3000 | Green (RoHS & no Sb/Br) | CU NIPDAU CU SN | Level-1-260C-UNLIM | -40 to 125 | (08 ~ C08Q ~ C08R) (CR ~ CZ) | Samples |
| SN74LVC2G08DCURE4 | ACTIVE | VSSOP | DCU | 8 | 3000 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM | -40 to 125 | C08R | Samples |
| SN74LVC2G08DCURG4 | ACTIVE | VSSOP | DCU | 8 | 3000 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM | -40 to 125 | C08R | Samples |
| SN74LVC2G08DCUT | ACTIVE | VSSOP | DCU | 8 | 250 | Green (RoHS & no Sb/Br) | CU NIPDAU CU SN | Level-1-260C-UNLIM | -40 to 125 | (C08Q ~ C08R) CR | Samples |
| SN74LVC2G08DCUTG4 | ACTIVE | VSSOP | DCU | 8 | 250 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM | -40 to 125 | C08R | Samples |
| SN74LVC2G08YZPR | ACTIVE | DSBGA | YZP | 8 | 3000 | Green (RoHS & no Sb/Br) | SNAGCU | Level-1-260C-UNLIM | -40 to 85 | (CE7 ~ CEN) | Samples |

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

⁽²⁾ RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

⁽³⁾ MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.



PACKAGE OPTION ADDENDUM

3-Jul-2017

- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead/Ball Finish Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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OTHER QUALIFIED VERSIONS OF SN74LVC2G08:

Automotive: SN74LVC2G08-Q1

Enhanced Product: SN74LVC2G08-EP

NOTE: Qualified Version Definitions:

- Automotive Q100 devices qualified for high-reliability automotive applications targeting zero defects
- Enhanced Product Supports Defense, Aerospace and Medical Applications

PACKAGE MATERIALS INFORMATION

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TAPE AND REEL INFORMATION





| | Dimension designed to accommodate the component width |
|----|---|
| B0 | Dimension designed to accommodate the component length |
| K0 | Dimension designed to accommodate the component thickness |
| W | Overall width of the carrier tape |
| P1 | Pitch between successive cavity centers |

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

| Device | Package Type | Package Drawing | | SPQ | Reel Diameter (mm) | Reel Width W1 (mm) | A0 (mm) | B0 (mm) | K0 (mm) | P1 (mm) | W (mm) | Pin1 Quadrant |
|-------------------|-----------------|--------------------|---|------|--------------------------|--------------------------|------------|------------|------------|------------|-----------|------------------|
| SN74LVC2G08DCTR | SM8 | DCT | 8 | 3000 | 180.0 | 13.0 | 3.35 | 4.5 | 1.55 | 4.0 | 12.0 | Q3 |
| SN74LVC2G08DCUR | VSSOP | DCU | 8 | 3000 | 180.0 | 9.0 | 2.05 | 3.3 | 1.0 | 4.0 | 8.0 | Q3 |
| SN74LVC2G08DCUR | VSSOP | DCU | 8 | 3000 | 180.0 | 8.4 | 2.25 | 3.35 | 1.05 | 4.0 | 8.0 | Q3 |
| SN74LVC2G08DCUR | VSSOP | DCU | 8 | 3000 | 178.0 | 9.5 | 2.25 | 3.35 | 1.05 | 4.0 | 8.0 | Q3 |
| SN74LVC2G08DCURG4 | VSSOP | DCU | 8 | 3000 | 180.0 | 8.4 | 2.25 | 3.35 | 1.05 | 4.0 | 8.0 | Q3 |
| SN74LVC2G08DCUT | VSSOP | DCU | 8 | 250 | 178.0 | 9.5 | 2.25 | 3.35 | 1.05 | 4.0 | 8.0 | Q3 |
| SN74LVC2G08DCUT | VSSOP | DCU | 8 | 250 | 180.0 | 8.4 | 2.25 | 3.35 | 1.05 | 4.0 | 8.0 | Q3 |
| SN74LVC2G08DCUTG4 | VSSOP | DCU | 8 | 250 | 180.0 | 8.4 | 2.25 | 3.35 | 1.05 | 4.0 | 8.0 | Q3 |
| SN74LVC2G08YZPR | DSBGA | YZP | 8 | 3000 | 178.0 | 9.2 | 1.02 | 2.02 | 0.63 | 4.0 | 8.0 | Q1 |

PACKAGE MATERIALS INFORMATION

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*All dimensions are nominal

| Device | Package Type | Package Drawing | Pins | SPQ | Length (mm) | Width (mm) | Height (mm) |
|-------------------|--------------|-----------------|------|------|-------------|------------|-------------|
| SN74LVC2G08DCTR | SM8 | DCT | 8 | 3000 | 182.0 | 182.0 | 20.0 |
| SN74LVC2G08DCUR | VSSOP | DCU | 8 | 3000 | 182.0 | 182.0 | 20.0 |
| SN74LVC2G08DCUR | VSSOP | DCU | 8 | 3000 | 202.0 | 201.0 | 28.0 |
| SN74LVC2G08DCUR | VSSOP | DCU | 8 | 3000 | 202.0 | 201.0 | 28.0 |
| SN74LVC2G08DCURG4 | VSSOP | DCU | 8 | 3000 | 202.0 | 201.0 | 28.0 |
| SN74LVC2G08DCUT | VSSOP | DCU | 8 | 250 | 202.0 | 201.0 | 28.0 |
| SN74LVC2G08DCUT | VSSOP | DCU | 8 | 250 | 202.0 | 201.0 | 28.0 |
| SN74LVC2G08DCUTG4 | VSSOP | DCU | 8 | 250 | 202.0 | 201.0 | 28.0 |
| SN74LVC2G08YZPR | DSBGA | YZP | 8 | 3000 | 220.0 | 220.0 | 35.0 |

DCT (R-PDSO-G8)

PLASTIC SMALL-OUTLINE PACKAGE



NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion
- D. Falls within JEDEC MO-187 variation DA.

DCT (R-PDSO-G8)

PLASTIC SMALL OUTLINE



NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.





DIE SIZE BALL GRID ARRAY



NOTES:

- All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
- 2. This drawing is subject to change without notice.



DIE SIZE BALL GRID ARRAY



NOTES: (continued)

3. Final dimensions may vary due to manufacturing tolerance considerations and also routing constraints. For more information, see Texas Instruments literature number SNVA009 (www.ti.com/lit/snva009).



DIE SIZE BALL GRID ARRAY



NOTES: (continued)

4. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release.



DCU (R-PDSO-G8)

PLASTIC SMALL-OUTLINE PACKAGE (DIE DOWN)



NOTES:

- : A. All linear dimensions are in millimeters.
 - B. This drawing is subject to change without notice.
 - C. Body dimensions do not include mold flash or protrusion. Mold flash and protrusion shall not exceed 0.15 per side.
 - D. Falls within JEDEC MO-187 variation CA.



DCU (S-PDSO-G8)

PLASTIC SMALL OUTLINE PACKAGE (DIE DOWN)



NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



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